

**Notice of References Cited**

Application/Control No.

09/756;451

Applicant(s)/Patent Under  
Reexamination  
EDWARDS ET AL.

Examiner

Monica A Fontaine

Art Unit

1732

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-3,993,726	11-1976	Moyer, Richard L.	264/171.12
	B	US-5,614,228	03-1997	Demerest, A. Edward	425/326.1
	C	US-5,798,067	08-1998	Long, Sr., Robert T.	264/134
	D	US-5,891,379	04-1999	Bhattacharyya et al.	264/280
	E	US-6,086,800	07-2000	Manlove, Steven F.	264/37.32
	F	US-6,256,146	07-2001	Merrill et al.	359/500
	G	US-5,591,463	01-1997	Padovani, Pietro	425/359
	H	US-4,058,581	11-1977	Park, Im K.	264/136
	I	US-5,433,419	07-1995	Murakami, Haruji	264/136
	J	US-5,106,567	04-1992	Demerest, A. Edward	264/503
	K	US-5,632,838	05-1997	Weidner, Richard A.	156/180
	L	US-4,559,262	12-1985	Cogswell et al.	428/298.7
	M	US-4,037,011	07-1977	Hattori et al.	428/299.4

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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